

# MBN800E33E

Silicon N-channel IGBT 3300V E version

## FEATURES

- \* Soft switching behavior & low conduction loss:
  - Soft low-injection punch-through
  - High conductivity IGBT.
- \* Low driving power due to low input capacitance MOS gate.
- \* Low noise recovery: Ultra soft fast recovery diode.

## ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C)

Item	Symbol	Unit	MBN800E33E
Collector Emitter Voltage	V <sub>CEs</sub>	V	3,300
Gate Emitter Voltage	V <sub>GES</sub>	V	±20
Collector Current	DC	I <sub>C</sub>	800
	1ms	I <sub>CRM</sub>	1,600
Forward Current	DC	I <sub>F</sub>	800
	1ms	I <sub>FRM</sub>	1,600
Junction Temperature	T <sub>vi,op</sub>	°C	-50 ~ +125
Storage Temperature	T <sub>stg</sub>	°C	-40 ~ +125
Isolation Voltage	V <sub>ISO</sub>	V <sub>RMS</sub>	6,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/15 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value 1.8±0.2/15<sup>+0</sup><sub>-3</sub>N·m (2) Recommended Value 5.5±0.5N·m

## ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	I <sub>CEs</sub>	mA	-	-	12	V <sub>CE</sub> =3,300V, V <sub>GE</sub> =0V, T <sub>vi</sub> =25°C
Gate Emitter Leakage Current	I <sub>GES</sub>	nA	-500	-	+500	V <sub>CE</sub> =3,300V, V <sub>GE</sub> =0V, T <sub>vi</sub> =125°C
Collector Emitter Saturation Voltage	V <sub>CEsat</sub>	V	3.0	3.5	4.2	I <sub>C</sub> =800A, V <sub>GE</sub> =15V, T <sub>vi</sub> =125°C
Gate Emitter Threshold Voltage	V <sub>GE(th)</sub>	V	4.5	6.0	7.0	V <sub>CE</sub> =10V, I <sub>C</sub> =800mA, T <sub>vi</sub> =25°C
Input Capacitance	C <sub>ies</sub>	nF	-	70	-	V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=100kHz, T <sub>vi</sub> =25°C
Internal Gate Resistance	R <sub>G(int)</sub>	Ω	-	2.0	-	V <sub>CE</sub> =10V, V <sub>GE</sub> =0V, f=100kHz, T <sub>vi</sub> =25°C
Turn On Delay Time	t <sub>d(on)</sub>	μs	-	0.4	-	V <sub>CC</sub> =1,650V, I <sub>C</sub> =800A
Rise Time	t <sub>r</sub>		1.1	2.1	3.1	L <sub>S</sub> =120nH
Turn Off Delay Time	t <sub>d(off)</sub>		-	2.0	-	R <sub>G</sub> =5.6Ω (3)
Fall Time	t <sub>f</sub>		1.3	2.2	3.1	V <sub>GE</sub> =±15V, T <sub>vi</sub> =125°C
Peak Forward Voltage Drop	V <sub>F</sub>	V	2.0	2.5	3.0	I <sub>F</sub> =800A, V <sub>GE</sub> =0V, T <sub>vi</sub> =125°C
Reverse Recovery Time	t <sub>rr</sub>	μs	0.2	0.7	1.2	V <sub>CC</sub> =1,650V, I <sub>F</sub> =800A, L <sub>S</sub> =120nH T <sub>vi</sub> =125°C
Turn On Loss	E <sub>on(10%)</sub>	J/P	-	1.2	1.6	V <sub>CC</sub> =1,650V, I <sub>C</sub> =800A, L <sub>S</sub> =120nH
Turn Off Loss	E <sub>off(10%)</sub>	J/P	-	1.3	1.7	R <sub>G</sub> =5.6Ω (3)
Reverse Recovery Loss	E <sub>rr(10%)</sub>	J/P	-	1.0	1.5	V <sub>GE</sub> =±15V, T <sub>vi</sub> =125°C
Short Circuit Pulse Width	t <sub>sc</sub>	μs	10	-	-	V <sub>CC</sub> =2,000V, L <sub>S</sub> =120nH R <sub>G(on/off)</sub> =5.6/56Ω, V <sub>GE</sub> =±15V, T <sub>vi</sub> =125°C
Stray inductance module	L <sub>SCE</sub>	nH	-	18	-	
Thermal Impedance	IGBT	R <sub>th(j-c)</sub>	-	-	0.013	Junction to case
	FWD	R <sub>th(j-c)</sub>	-	-	0.026	
Contact Thermal Impedance	R <sub>th(c-f)</sub>	K/W	-	0.008	-	Case to fin

Notes: (3) R<sub>G</sub> value is a test condition value for evaluation, not recommended value.  
Please, determine the suitable R<sub>G</sub> value by measuring switching behaviors.

- \* Please contact our representatives at order.
- \* For improvement, specifications are subject to change without notice.
- \* For actual application, please confirm this spec sheet is the newest revision.

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## DEFINITION OF TEST CIRCUIT

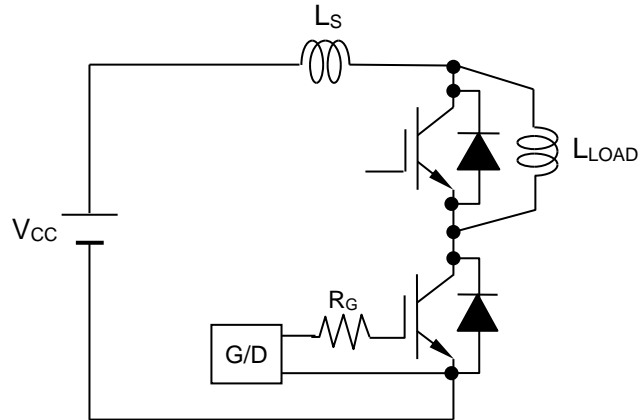


Fig.1 Switching test circuit

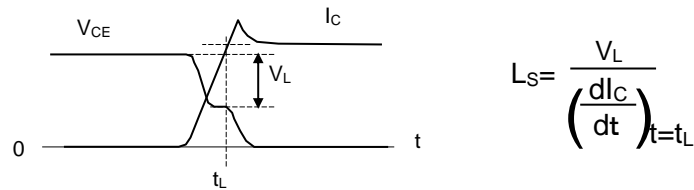


Fig.2 Definition of stray inductance

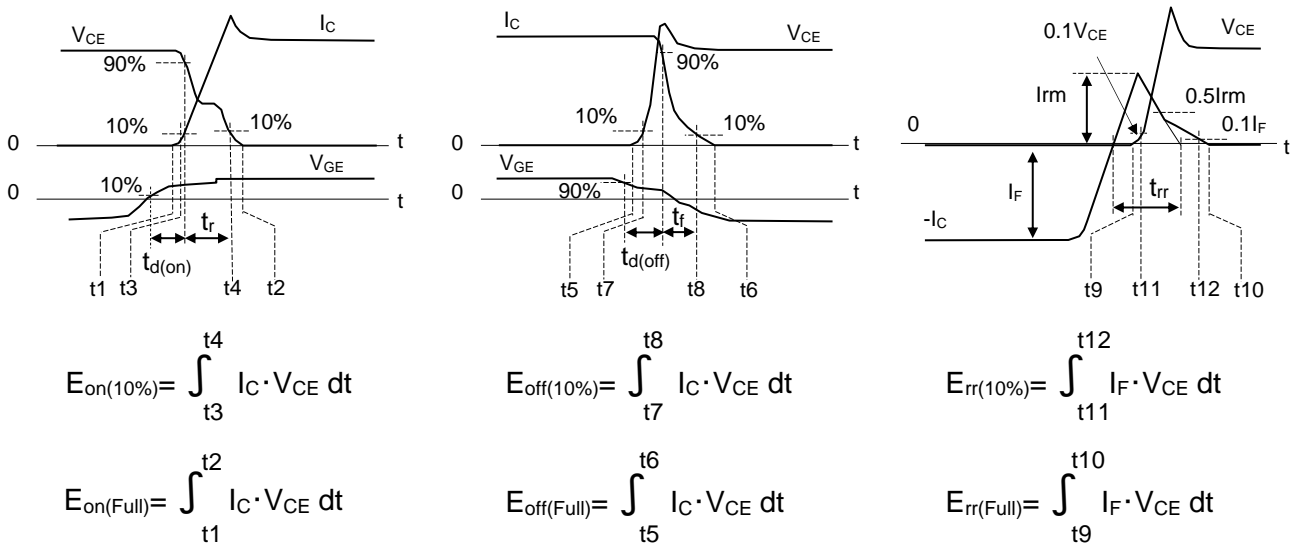
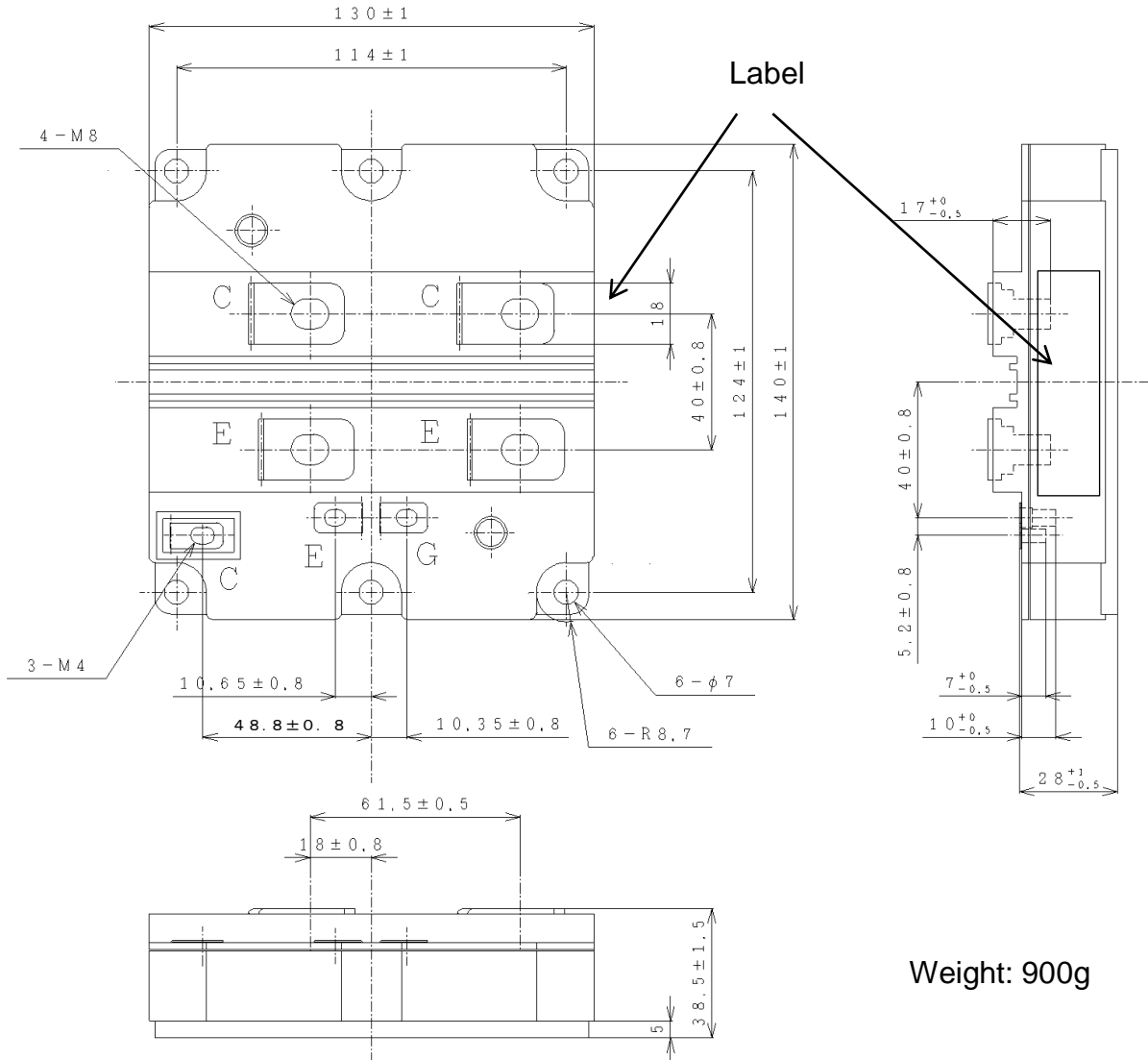


Fig.3 Definition of switching loss

# MBN800E33E

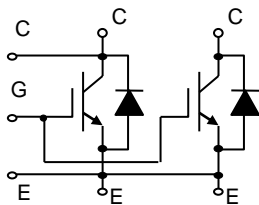
## OUTLINE DRAWING

Unit in mm

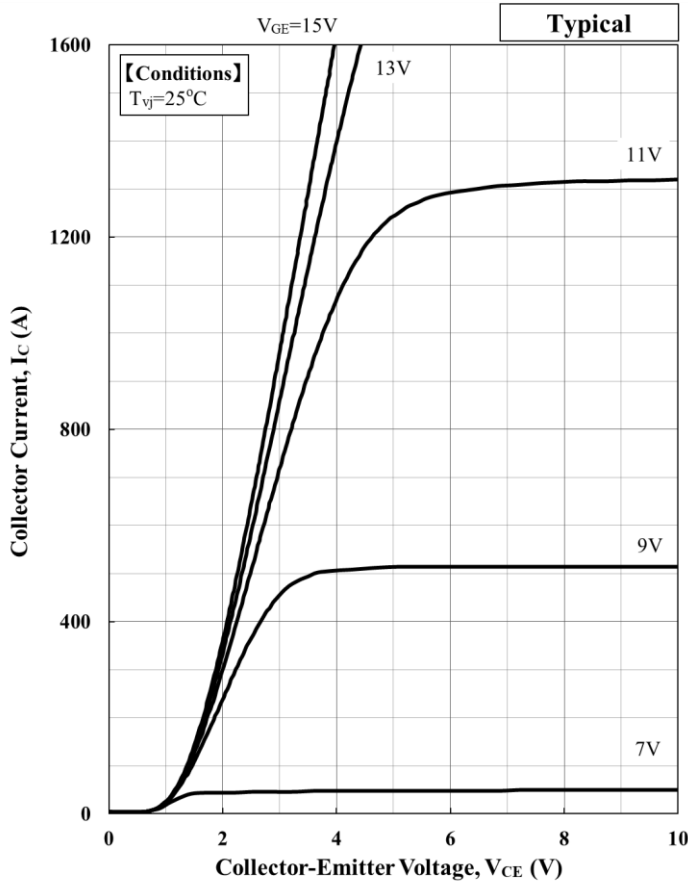


Weight: 900g

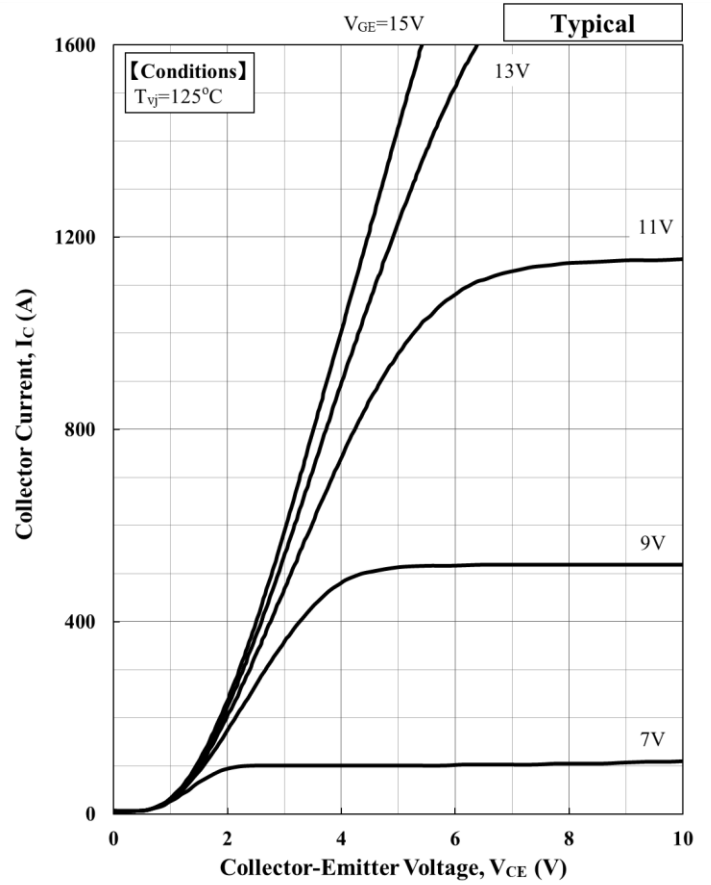
## CIRCUIT DIAGRAM



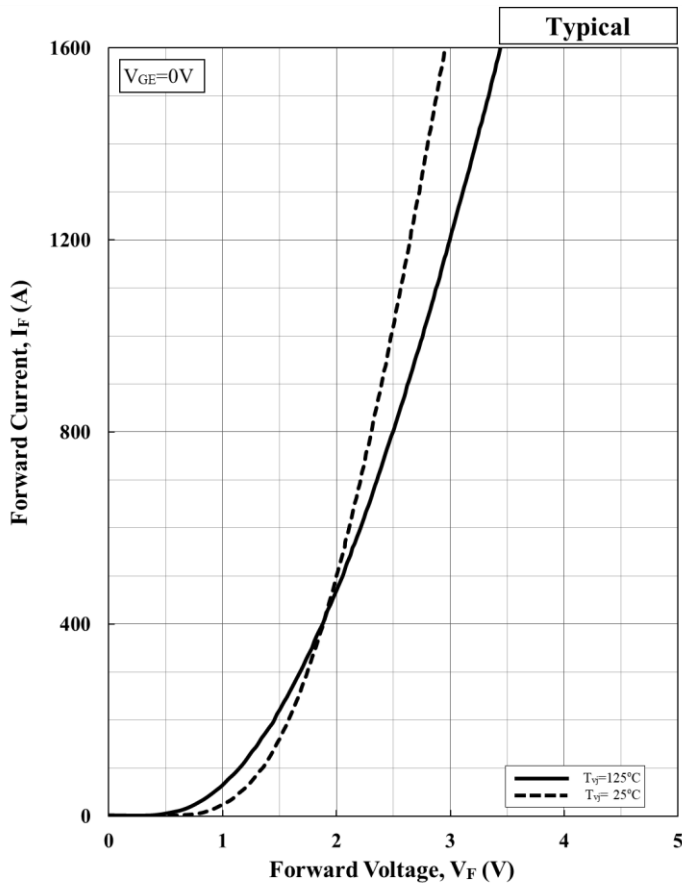
# MBN800E33E



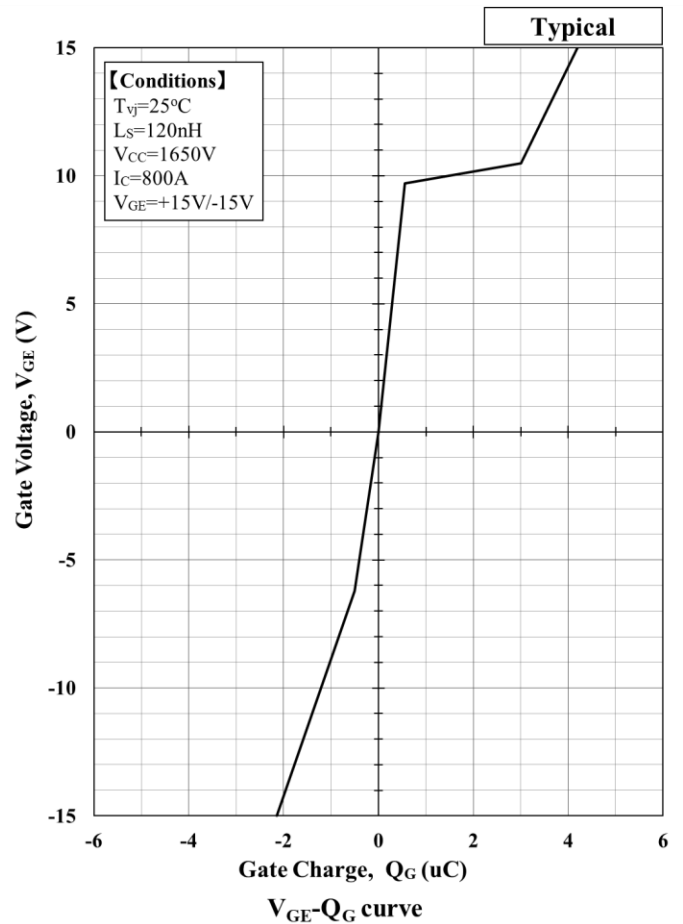
Collector Current vs. Collector Emitter Voltage



Collector Current vs. Collector Emitter Voltage

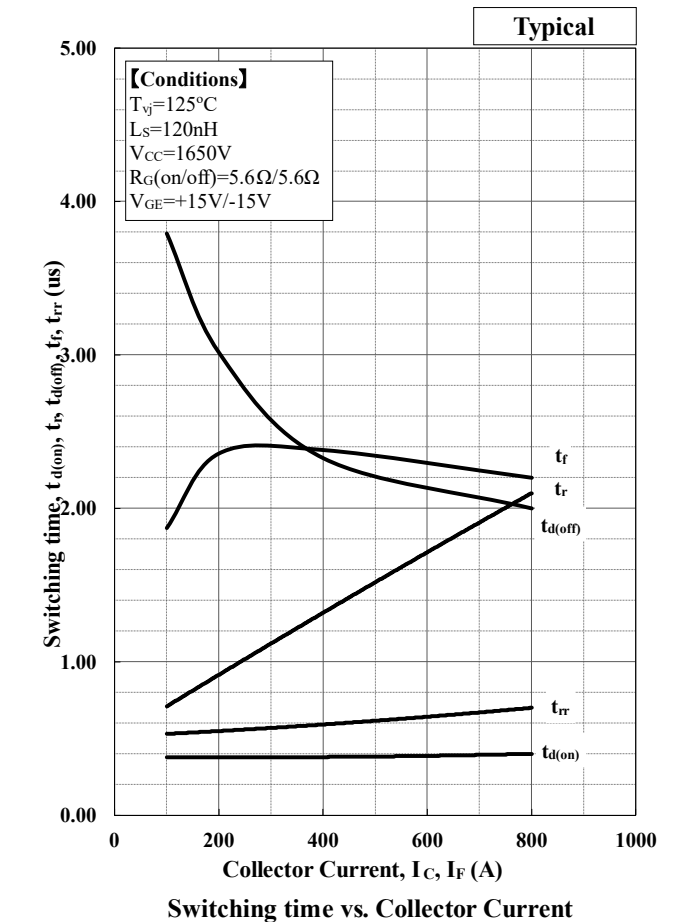
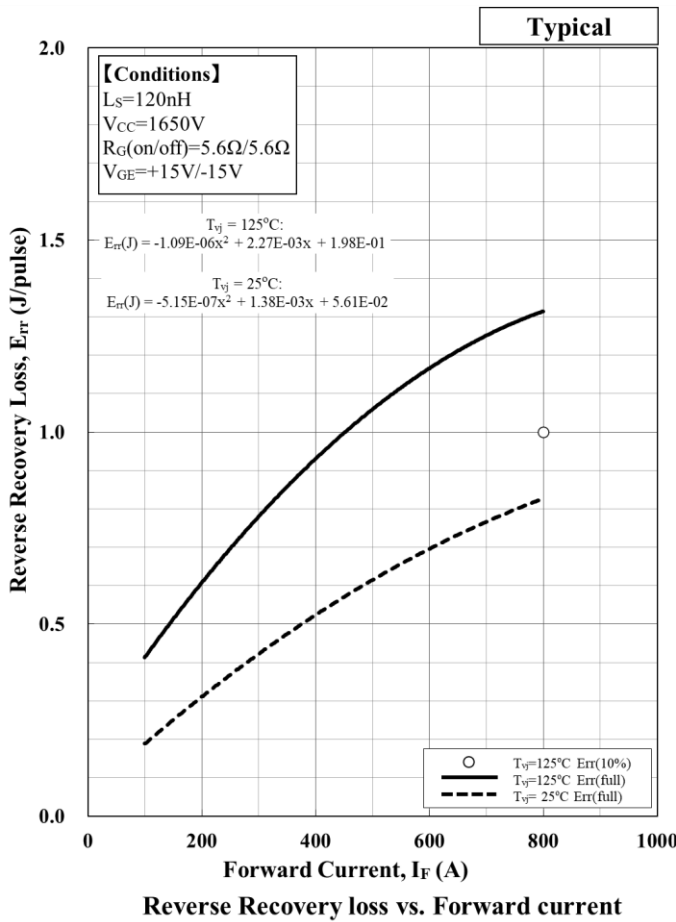
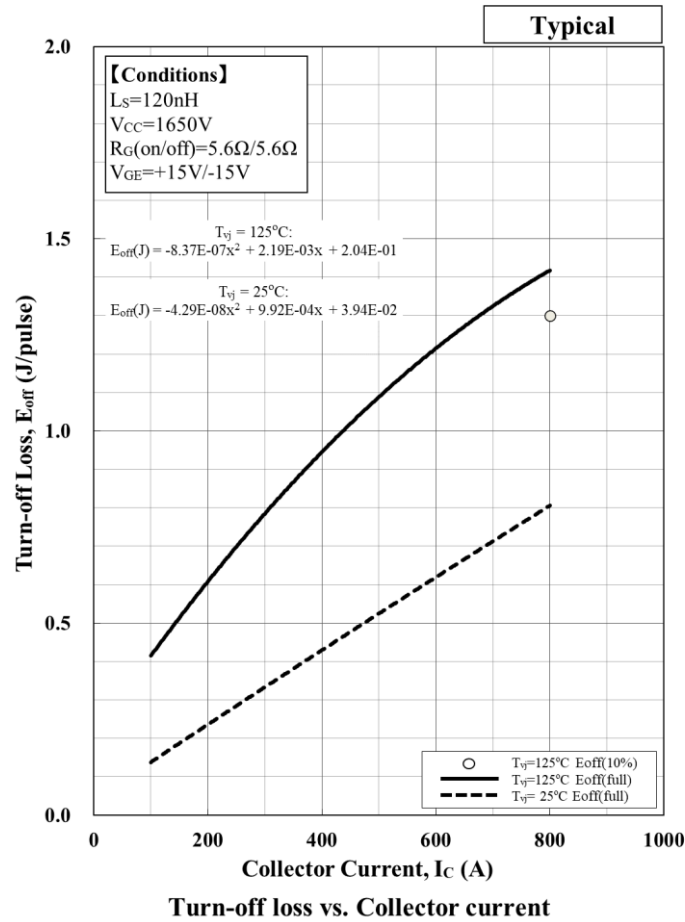
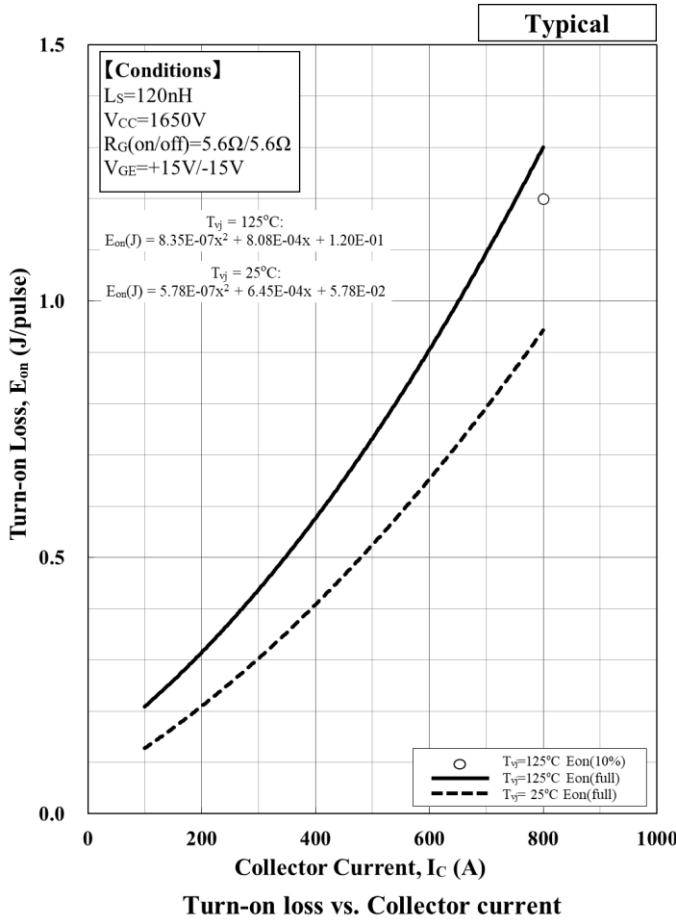


Forward Voltage of free-wheeling diode

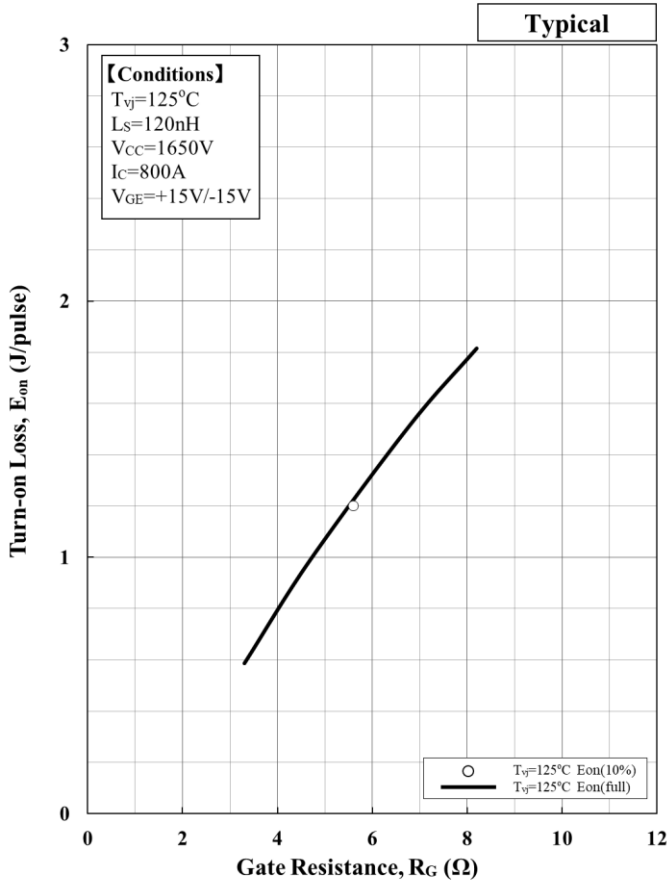


V<sub>GE</sub>-Q<sub>G</sub> curve

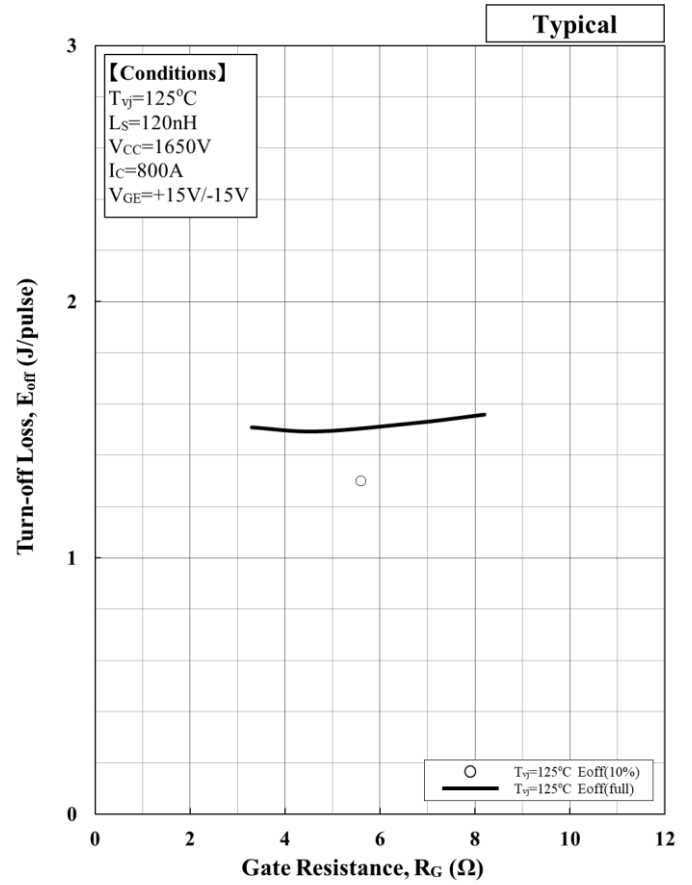
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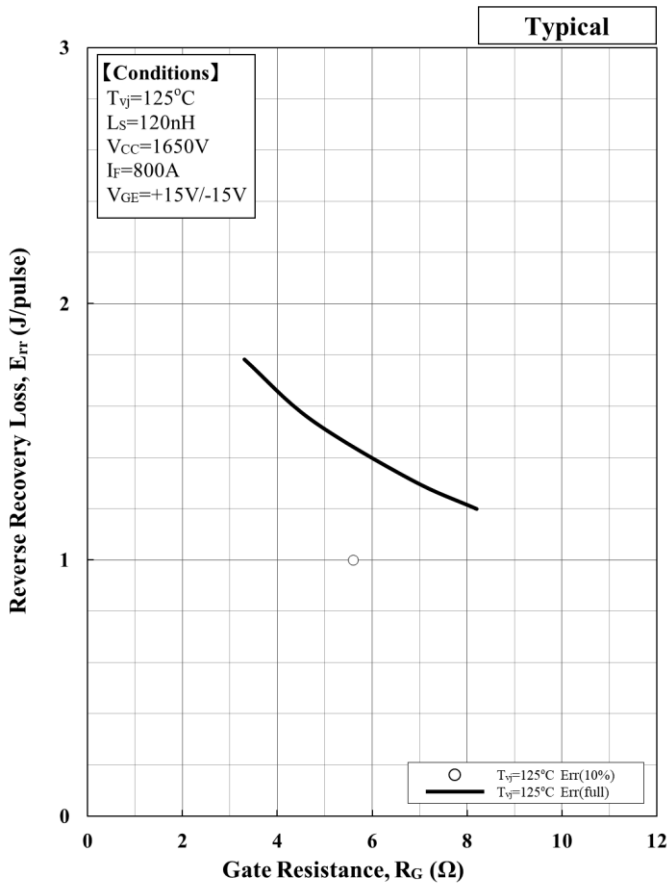
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Turn-on loss vs. Gate Resistance

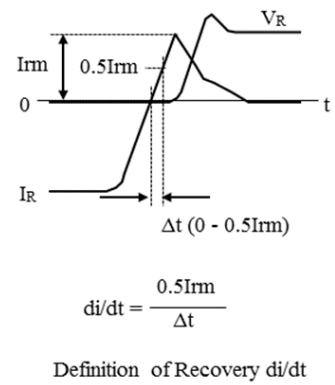
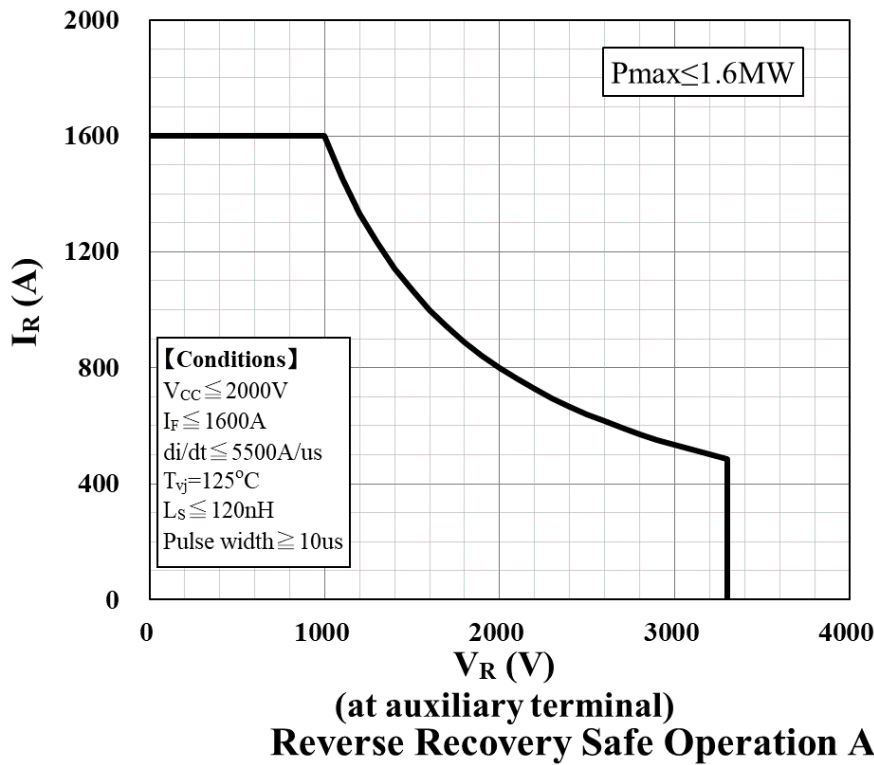
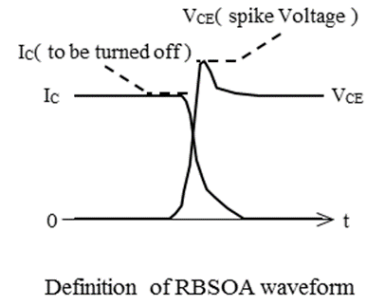
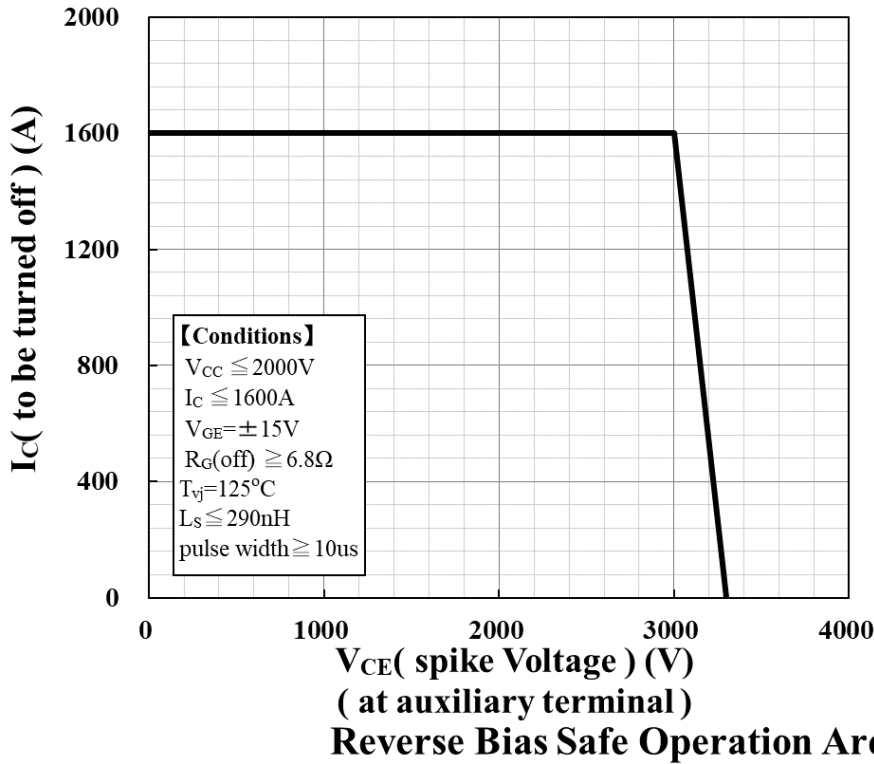


Turn-off loss vs. Gate Resistance

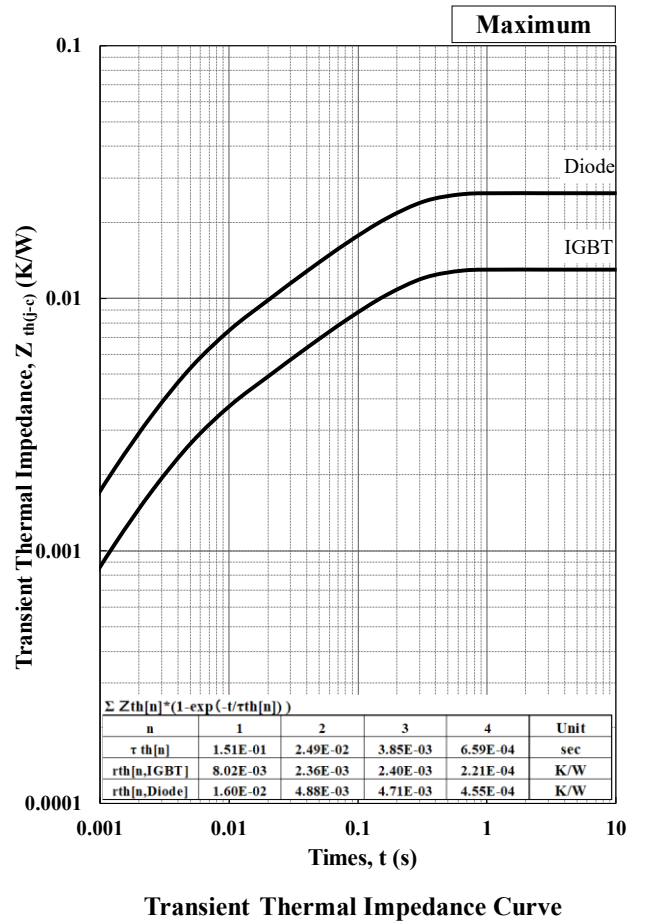
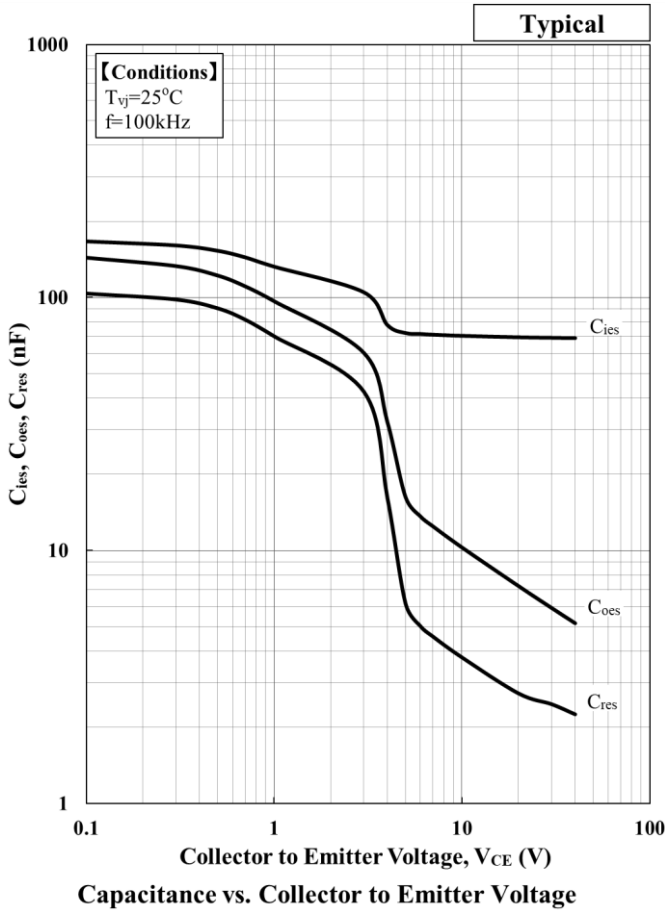


Reverse Recovery loss vs. Gate Resistance

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**Material declaration**

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder



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## Minebea POWER SEMICONDUCTORS

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